

Search Notes

Application/Control No.

10/804,745

Examiner

TAN Q. NGUYEN

Applicant(s)/Patent under
Reexamination

PERISHO ET AL

Art Unit

3661

SEARCHED

Class	Subclass	Date	Examiner
701	96,72,74 78,79,301	1/31/2007	TN
180	170		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PLUS SEARCH	1/9/2007	TN
EAST SEARCH	1/31/2007	TN